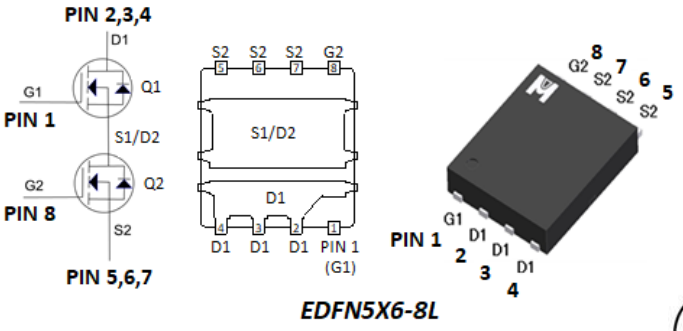
杰力科技股份有限公司
Excelliance MOS Corporation

EMB06K03HP

Dual N-Channel Logic Level Enhancement Mode Field Effect Transistor

Product Summary:

	N-CH-Q1	N-CH-Q2
BV_{DSS}	30V	30V
$R_{DSON\ (MAX.)}$	9.5mΩ	6.5mΩ
I_D	11A	14A



EDFN5X6-8L

Dual N Channel MOSFET

UIS, Rg 100% Tested

RoHS & Halogen Free & TSCA Compliant

ABSOLUTE MAXIMUM RATINGS (T_C = 25 °C Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS		UNIT
			Q1	Q2	
Gate-Source Voltage		V_{GS}	±20	±20	V
Continuous Drain Current	T_A = 25 °C	I_D	11	14	A
	T_A = 100 °C		7	9	
Pulsed Drain Current[1]		I_{DM}	44	56	
Avalanche Current		I_{AS}	32	38	
Avalanche Energy	L = 0.1mH	E_{AS}	51.2	72.2	mJ
Repetitive Avalanche Energy[2]	L = 0.05mH	E_{AR}	25.6	36.1	
Power Dissipation	T_A = 25 °C	P_D	2.0	2.3	W
	T_A = 100 °C		0.8	0.9	
Operating Junction & Storage Temperature Range		T_j, T_{stg}	-55 to 150		°C

▪100% UIS testing in condition of VD=30V, L=0.1mH, VG=10V, IL=20A,RG=25Ω,Rated VDS=30V N-CH_Q1

▪100% UIS testing in condition of VD=30V, L=0.1mH, VG=10V, IL=23A,RG=25Ω,Rated VDS=30V N-CH_Q2

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM		UNIT
Junction-to-Case	$R_{\theta JC}$		2.6	1.8	°C / W
Junction-to-Ambient	$R_{\theta JA}$		62	55	

[1]Pulse width limited by maximum junction temperature.

[2]Duty cycle < 1%

[3]The value of $R_{\theta JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C.

[4]Guarantee by Engineering test

ELECTRICAL CHARACTERISTICS (T_C = 25 °C, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS		LIMITS MIN	LIMITS TYP	LIMITS MAX	UNIT
STATIC							
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	V_{GS} = 0V, I_D = 250μA	Q1	30			V
			Q2	30			
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS} = V_{GS}, I_D = 250μA	Q1	1	1.5	3	
			Q2	1	1.5	3	
Gate-Body Leakage	I_{GSS}	V_{DS} = 0V, V_{GS} = ±20V	Q1			±100	nA
			Q2			±100	
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = 24V, V_{GS} = 0V	Q1			1	μA
			Q2			1	
		V_{DS} = 20V, V_{GS} = 0V, T_J = 125 °C	Q1			25	
			Q2			25	
On-State Drain Current[1]	$I_{D(ON)}$	V_{DS} = 10V, V_{GS} = 10V	Q1	15			A
			Q2	25			
Drain-Source On-State Resistance[1]	$R_{DS(ON)}$	V_{GS} = 10V, I_D = 13A	Q1		8.2	9.5	mΩ
		V_{GS} = 10V, I_D = 20A	Q2		5.2	6.5	
		V_{GS} = 4.5V, I_D = 9A	Q1		11	15	
		V_{GS} = 4.5V, I_D = 15A	Q2		7.0	9.5	
Forward Transconductance[1]	g_{fs}	V_{DS} = 5V, I_D = 13A	Q1		18		S
		V_{DS} = 5V, I_D = 20A	Q2		22		
DYNAMIC							
Input Capacitance	C_{iss}	V_{GS} = 0V, V_{DS} = 15V, f = 1MHz	Q1		828		pF
			Q2		1983		
Output Capacitance	C_{oss}		Q1		196		
			Q2		328		
Reverse Transfer Capacitance	C_{rss}		Q1		174		
			Q2		287		
Gate Resistance	R_g	V_{GS} = 15mV, V_{DS} = 0V, f = 1MHz	Q1		1.7		Ω
			Q2		1.2		
Total Gate Charge[1,2]	Q_g(V_{GS}=10V)	V_{DD} = 15V, V_{GS} = 10V, I_D = 10A	Q1		17.6		nC
			Q2		53		
	Q_g(V_{GS}=4.5V)		Q1		12.5		
			Q2		25		

Gate-Source Charge[1,2]	Q_{gs}	V_{DD} = 15V, V_{GS} = 10V, I_D = 10A	Q1		2.8		
			Q2		6		
Gate-Drain Charge[1,2]	Q_{gd}		Q1		7.4		
			Q2		10		
Turn-On Delay Time[1,2]	$t_{d(on)}$	V_{DD} = 15V, I_D = 5A, V_{GS} = 10V, R_G = 3Ω	Q1		8		nS
			Q2		9		
Rise Time[1,2]	t_r		Q1		18		
			Q2		20		
Turn-Off Delay Time[1,2]	$t_{d(off)}$		Q1		20		
			Q2		25		
Fall Time[1,2]	t_f		Q1		12		
			Q2		15		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T_C = 25 °C)							
Continuous Current	I_S		Q1			11	A
			Q2			14	
Pulsed Current[3]	I_{SM}		Q1			44	
			Q2			56	
Forward Voltage[1]	V_{SD}	I_F = 10A, V_{GS} = 0V	Q1			1.3	V
			Q2			1.3	
Reverse Recovery Time	t_{rr}	Q1 I_F = 10A, dI_F/dt = 100A / μS	Q1		22		nS
			Q2		28		
Reverse Recovery Charge	Q_{rr}	Q2 I_F = 10A, dI_F/dt = 100A / μS	Q1		6		nC
			Q2		18		

[1]Pulse test : Pulse Width ≤ 300 μsec, Duty Cycle ≤ 2%.

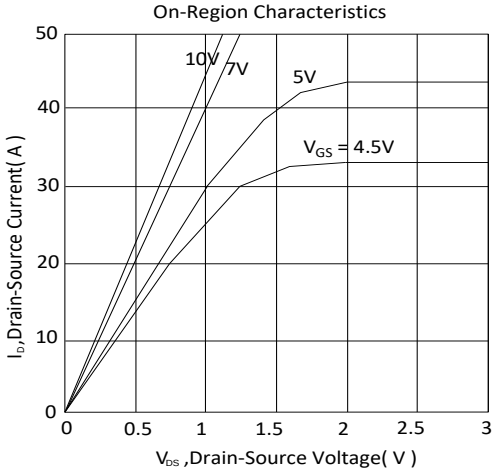
[2]Independent of operating temperature.

[3]Pulse width limited by maximum junction temperature.

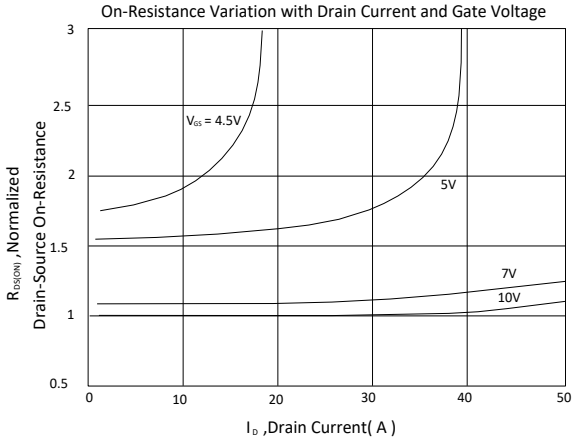
EMC will review datasheet by quarter, and update new version.

Q1 TYPICAL CHARACTERISTICS

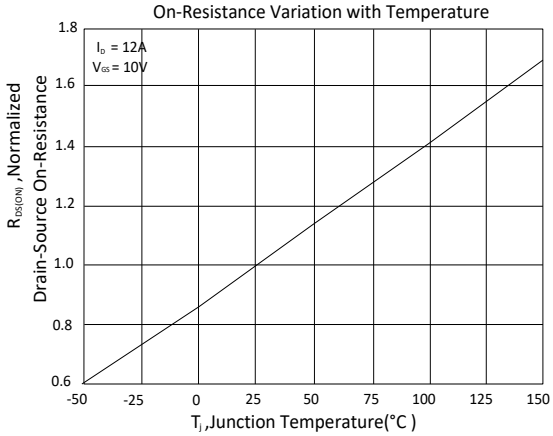
On-Region Characteristics



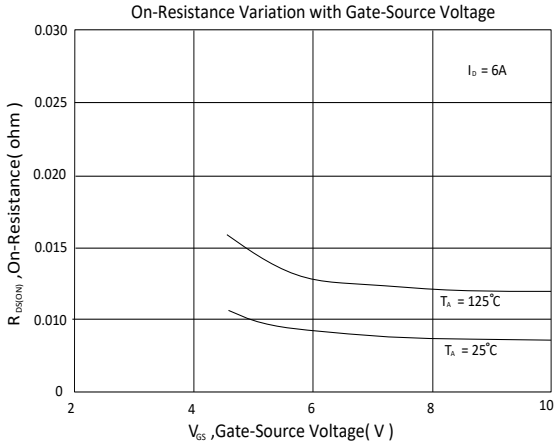
On-Resistance Variation with Drain Current and Gate Voltage



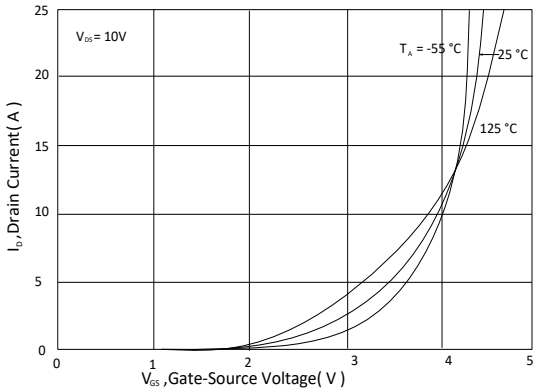
On-Resistance Variation with Temperature



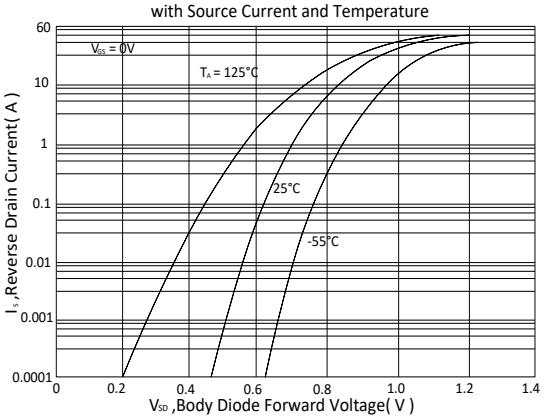
On-Resistance Variation with Gate-Source Voltage

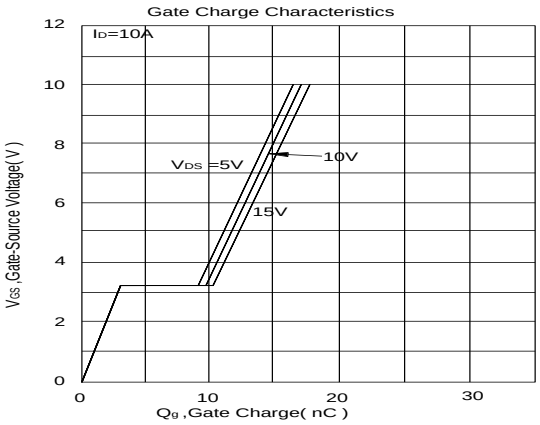


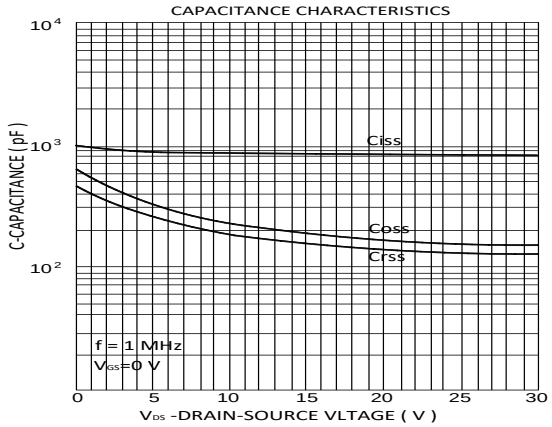
Transfer Characteristics

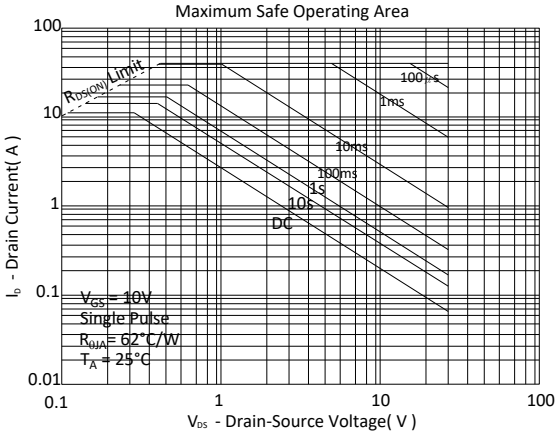


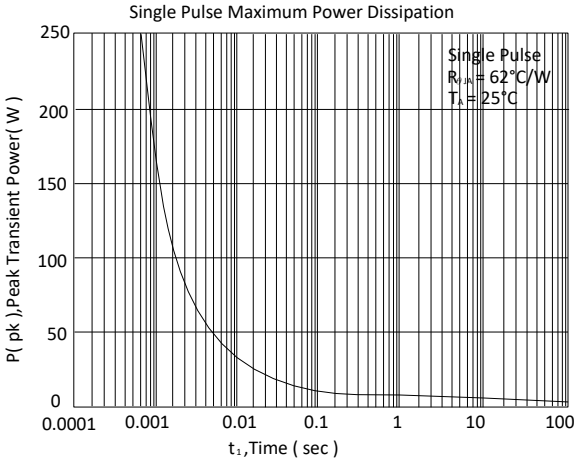
Body Diode Forward Voltage Variation with Source Current and Temperature

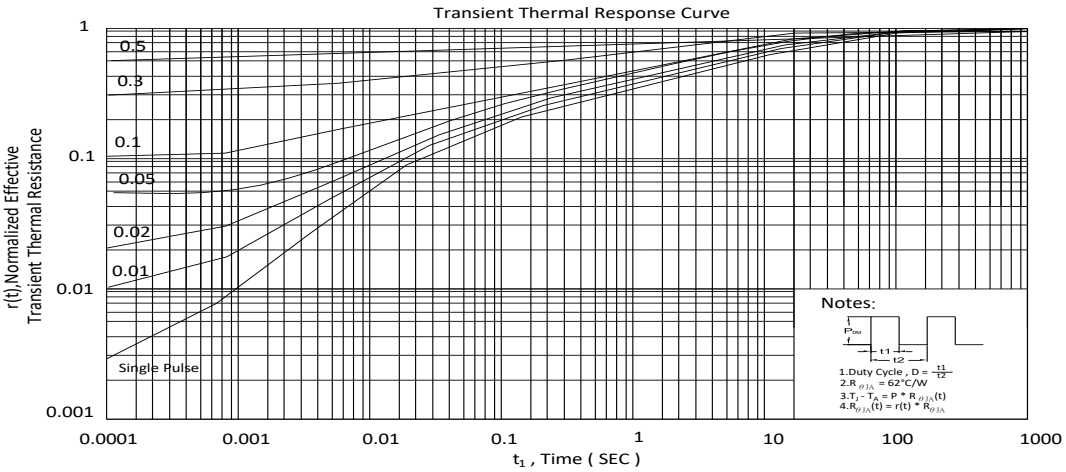



Gate Charge Characteristics
ID=10A
VDS =5V
10V
15V
VGS ,Gate-Source Voltage(V)
Qg ,Gate Charge(nC)


CAPACITANCE CHARACTERISTICS
Ciss
Coss
Crss
f = 1 MHz
VGS=0 V
C-CAPACITANCE (pF)
VDS -DRAIN-SOURCE VLTAGE (V)

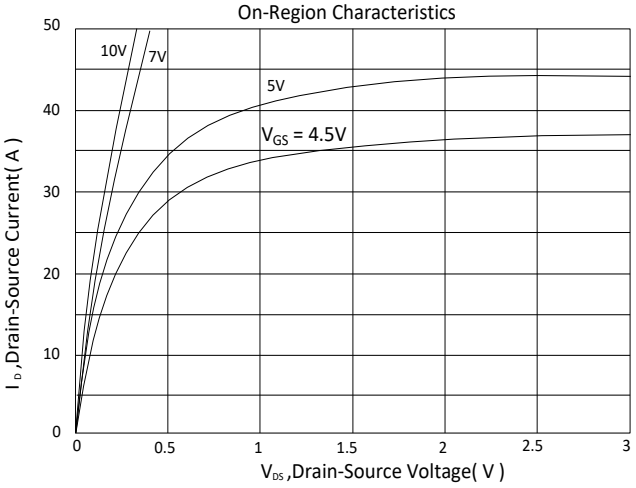

Maximum Safe Operating Area
RDS(ON) Limit
100 us
1ms
10ms
100ms
1S
10s
DC
VGS = 10V
Single Pulse
RθJA= 62°C/W
TA = 25°C
ID - Drain Current(A)
VDS - Drain-Source Voltage(V)


Single Pulse Maximum Power Dissipation
Single Pulse
RθJA = 62°C/W
TA = 25°C
P(pk),Peak Transient Power(W)
t1 ,Time (sec)

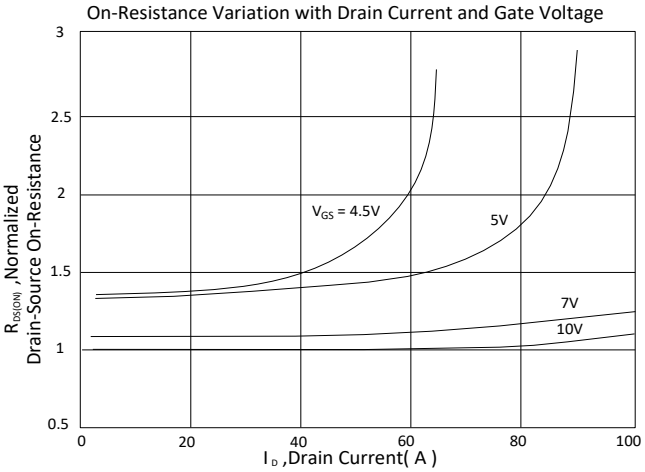

Transient Thermal Response Curve
0.5
0.3
0.1
0.05
0.02
0.01
Single Pulse
Notes:
1.Duty Cycle , D = t1/t2
2.RθJA = 62°C/W
3.TJ - TA = P * RθJA(t)
4.RθJA(t) = r(t) * RθJA
r(t),Normalized Effective Transient Thermal Resistance
t1 , Time (SEC)

Q2 TYPICAL CHARACTERISTICS

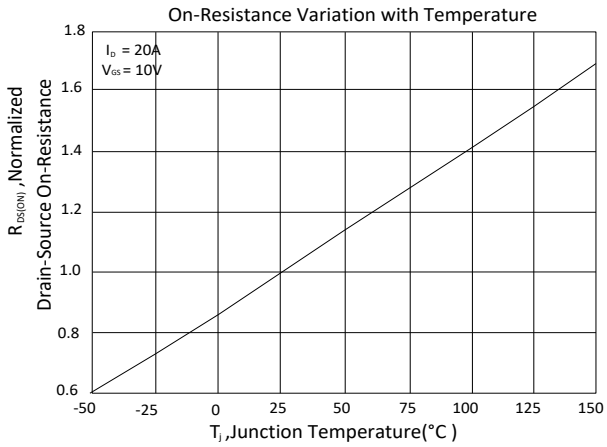
On-Region Characteristics



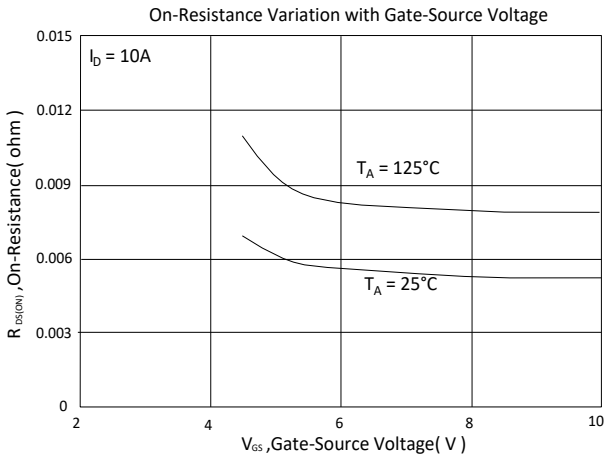
On-Resistance Variation with Drain Current and Gate Voltage



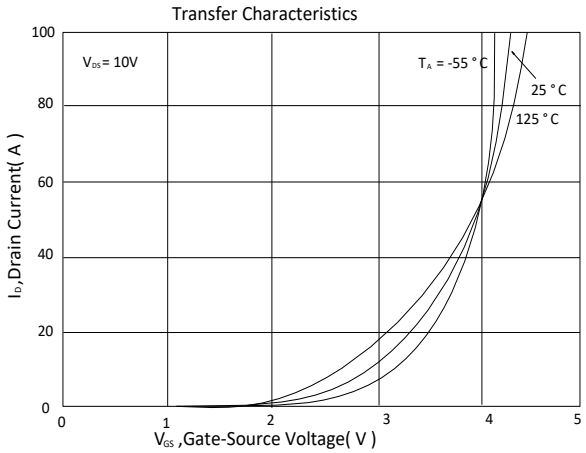
On-Resistance Variation with Temperature



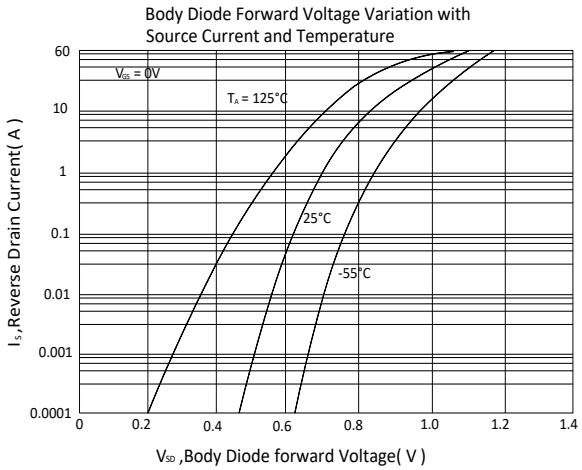
On-Resistance Variation with Gate-Source Voltage

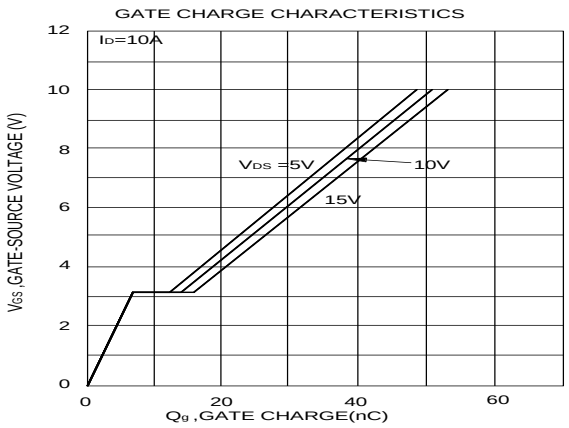


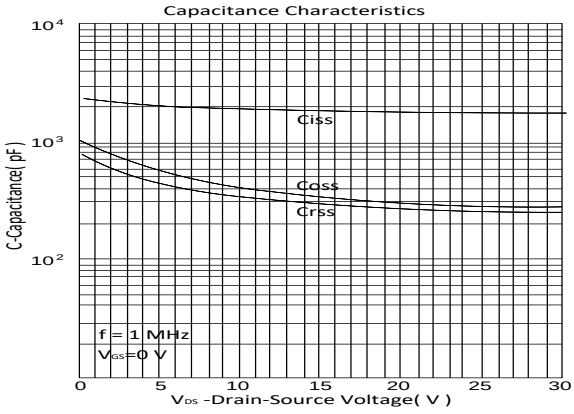
Transfer Characteristics

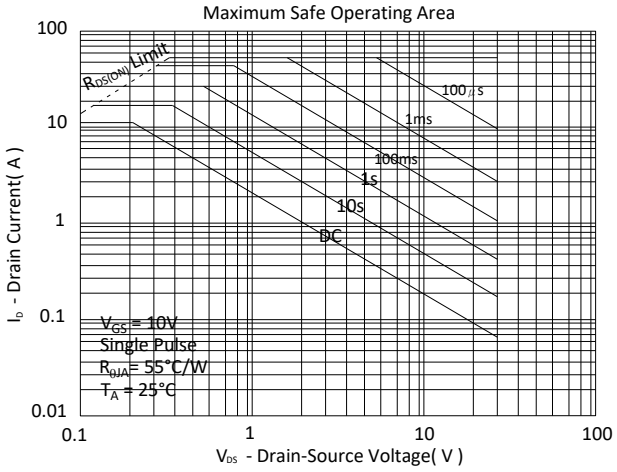


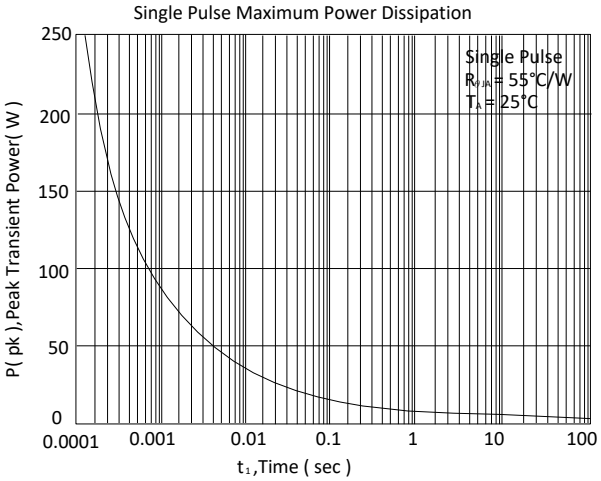
Body Diode Forward Voltage Variation with Source Current and Temperature

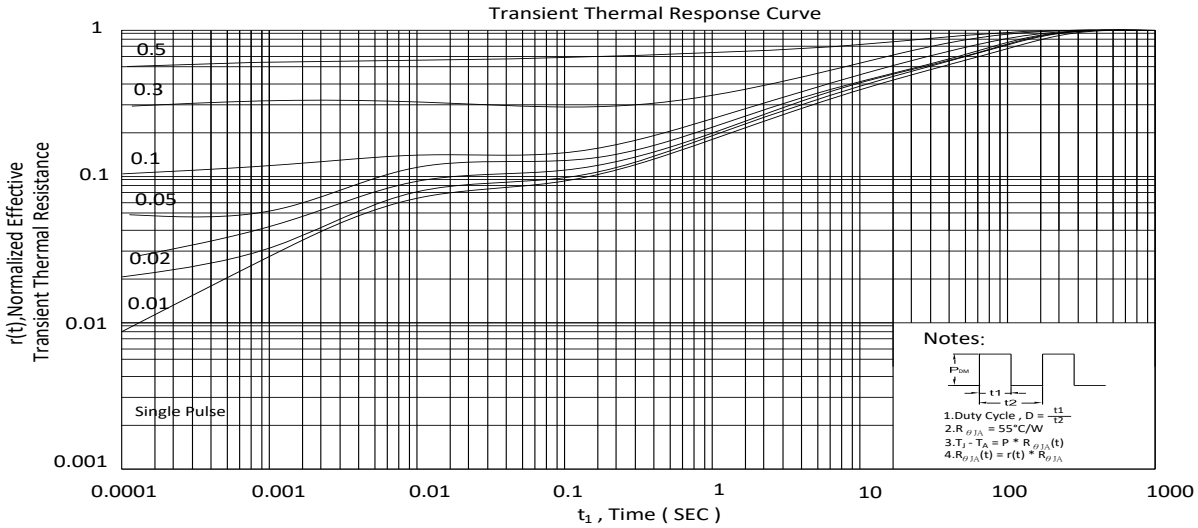



GATE CHARGE CHARACTERISTICS
ID=10A
VDS =5V
10V
15V
VGS ,GATE-SOURCE VOLTAGE (V)
Qg ,GATE CHARGE(nC)


Capacitance Characteristics
Ciss
Coss
Crss
f = 1 MHz
VGS=0 V
C-Capacitance(pF)
VDS -Drain-Source Voltage(V)


Maximum Safe Operating Area
RDS(ON) Limit
100μs
1ms
10ms
1s
10s
DC
VGS = 10V
Single Pulse
RθJA= 55°C/W
TA = 25°C
ID - Drain Current(A)
VDS - Drain-Source Voltage(V)


Single Pulse Maximum Power Dissipation
Single Pulse
RθJA = 55°C/W
TA = 25°C
P(pk),Peak Transient Power(W)
t1 ,Time (sec)


Transient Thermal Response Curve
0.5
0.3
0.1
0.05
0.02
0.01
Single Pulse
Notes:
1.Duty Cycle , D = t1/t2
2.RθJA = 55°C/W
3.TJ - TA = P * RθJA(t)
4.RθJA(t) = r(t) * RθJA
r(t),Normalized Effective Transient Thermal Resistance
t1 , Time (SEC)

Ordering & Marking Information:

Device Name: EMB06K03HP for Asymmetric Dual EDFN 5 x 6

EMB06K03HP: Device Name

ABCDEFG: Date Code

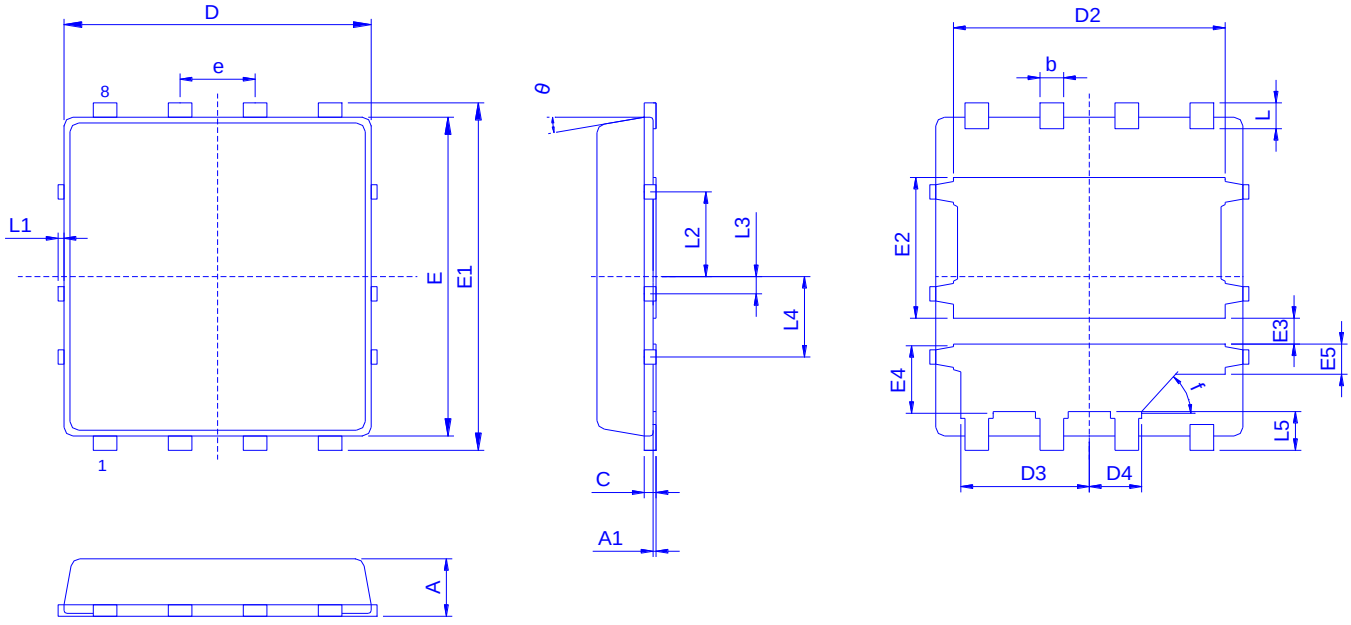
A: Assembly House

B: Year(A:2008 B:2009 C:2010….)

C: Month(A:01 B:02 C:03 D:04 E:05 F:06 G:07 H:08 I:09 J:10 K:11 L:12)

DEFG: Serial No.

Outline Drawing

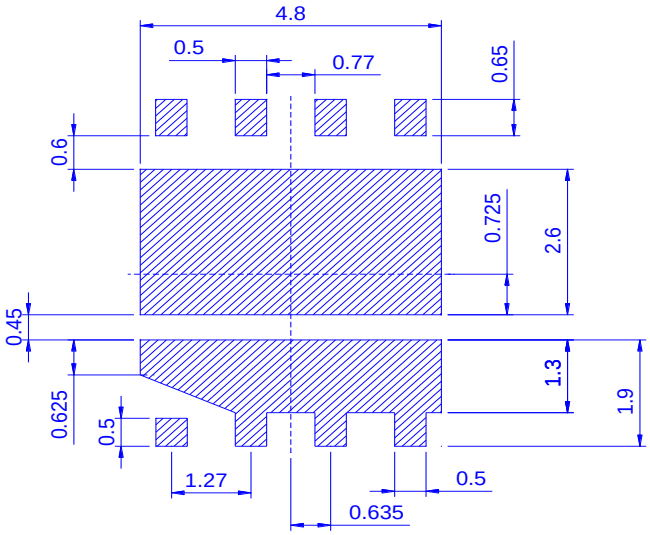


Dimension in mm

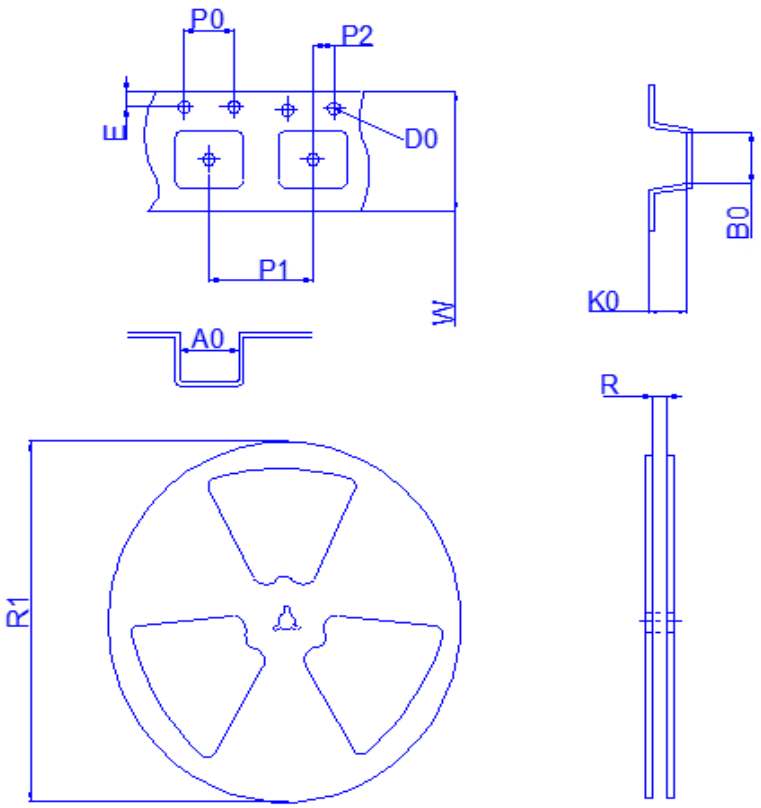
Dimension	A	A1	b	c	D	D2	D3	D4	E	E1	E2	E3	E4	E5
Min.	0.85	0.00	0.35	0.15		4.5	2.125	0.835			2.4	0.40	1.125	0.475
Typ.	0.90		0.40	0.20	5.2	4.6	2.175	0.885	5.55	6.05	2.45	0.45	1.175	0.525
Max.	1.00	0.05	0.45	0.25		4.7	2.225	0.935			2.5	0.50	1.225	0.575

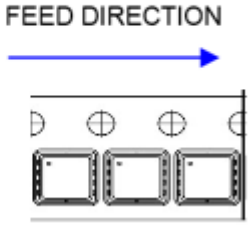
Dimension	e	L	L1	L2	L3	L4	L5	F	θ
Min.		0.35	0	1.375	0.2	1.3	0.575		0°
Typ.	1.27	0.45		1.475	0.3	1.4	0.675	45°	
Max.		0.55	0.1	1.575	0.4	1.5	0.775		10°

Recommended minimum pads



◆ Tape&Reel Information:2500pcs/Reel(Dimension in millimeter)



Package	EDFN5X6
Reel	13"
Device orientation	

Dimension in mm

Dimension	Carrier tape									Reel	
	A0	B0	D0	E	K0	P0	P1	P2	W	R	R1
Typ.	6.4	5.3	1.5	1.8	1.6	4.0	8.0	2.0	12.0	12.4	330.0
±	0.2	0.2	0.1	0.1	0.6	0.1	0.1	0.1	0.3	2.0	2.0